NOTES:

1. SUBSTRATE:

Fused Silica

2. COATING (APPLY ACROSS CLEAR APERTURE)

S1: P-POLARIZATION TRANSMISSION EFFICIENCY: >98% S-POLARIZATION REFLECTION EFFICIENCY: >99%

EXTINCTION RATIO: 10000:1

DAMAGE THRESHOLD,

PULSED: 2J/cm² @ 532nm, 10ns, S or P Polarization

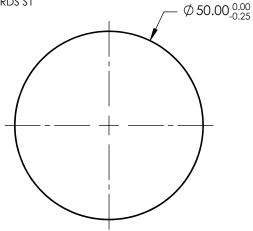


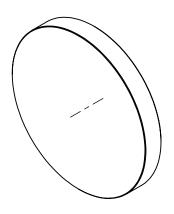
4. POWER, IRREGULARITY, SURFACE QUALITY, AND COATING SPECIFICATIONS APPLY ACROSS CLEAR APERTURE

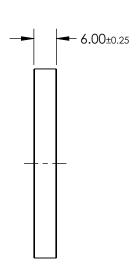
5. APPLY ARROW ON EDGE WTH PENCIL OR PERMANENT INK TOWARDS \$1

6. DESIGN WAVELENGTH: 355nm

7. ROHS COMPLIANT







FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	\$2	
TRANSMITTED WAVEFRONT	λ/4 @ 633nm	λ/4 @ 633nm	
ANGLE OF INCIDENCE (°)	45 ±2	45 ±2	
SHAPE	PLANO	PLANO	
SURFACE QUALITY	40 - 20	40 - 20	
CLEAR APERTURE	Ø 45.00	Ø 45.00	
BEVEL	PROTECTED AS NEEDED	PROTECTED AS NEEDED	

		Edmund Optics®			
THIRD ANGLE PROJECTION	355nm, 50mm Diameter, Thin Film Laser Line Beamsplitter		r Line		
ALL DIMS IN	mm	DWG NO	21885	SHEET 1 OF 1	